L Number	Hits	Search Text	DB	Time stamp
16	3	((chip or die) and (crack or cracking or bulging or bulge)) near adhesive	USPAT	2003/04/07 01:49
17	3	((chip or die) and (bulging or bulge or	USPAT	2003/04/07
18	492	crack or cracking)) near adhesive ((chip or die) with ((bend or bending or bulging or bulge or crack or cracking) and	USPAT	03:19 2003/04/07 00:51
19	99	tape)) and adhesive (((chip or die) with ((bend or bending or bulging or bulge or crack or cracking)and tape)) and adhesive) and	USPAT	2003/04/07 00:52
20	9	(adhesive near (chip or die)) ((chip or die) and (interposer or buffer)) near adhesive	USPAT	2003/04/07 01:03
21	411	(chip or die) and (tape adj substrate)	USPAT	2003/04/07 01:04
22	39	((chip or die) and (tape adj substrate)) and ((crack or cracking or bulging or bulge or bend or bending) with (chip or die or semiconductor or device))	USPAT	2003/04/07
23	18	(((chip or die) and (tape adj substrate)) and ((crack or cracking or bulging or bulge or bend or bending) with (chip or die or semiconductor or device))) and reflow	USPAT	2003/04/07 01:10
24	3984	((crack or cracking or bulging or bulge or bend or bending) near (chip or die or semiconductor or device))	USPAT	2003/04/07 02:46
25	60	(((crack or cracking or bulging or bulge or bend or bending) near (chip or die or semiconductor or device))) and ((chip or die) near adhesive)	USPAT	2003/04/07 01:31
26	20	<pre>((((crack or cracking or bulging or bulge or bend or bending) near (chip or die or semiconductor or device))) and ((chip or</pre>	USPAT	2003/04/07 01:36
27	9	die) near adhesive)) and reflow (((((crack or cracking or bulging or bulge or bend or bending) near (chip or die or semiconductor or device))) and ((chip or die) near adhesive)) and reflow) and moisture	USPAT	2003/04/07 01:46
28	1	("6541844").PN.	USPAT	2003/04/07
29	31	((crack or cracking or bulging or bulge or bend or bending) and substrate) near (polyimide or tape)	USPAT	2003/04/07 01:56
30	22	(((crack or cracking or bulging or bulge or bend or bending) and substrate) near (polyimide or tape)) and (@ad<19980728)	USPAT	2003/04/07 02:37
31	9	<pre>((((crack or cracking or bulging or bulge or bend or bending) and substrate) near (polyimide or tape)) and (@ad<19980728))</pre>	USPAT	2003/04/07
32	4	and (chip or die) ("5898213" "5951304" "6232650" "6285086").PN.	USPAT	2003/04/07 01:53
33	1299	(chip or die) and ((tape or polyimide) near substrate)	USPAT	2003/04/07 01:55
34	903	((chip or die) and ((tape or polyimide) near substrate)) and (@ad<19980728)	USPAT	2003/04/07
35	206	(((chip or die) and ((tape or polyimide) near substrate)) and (@ad<19980728)) and ((chip or die) near ((tape or polyimide)	USPAT	2003/04/07
36	71	or substrate)) ((((chip or die) and ((tape or polyimide) near substrate)) and (@ad<19980728)) and ((chip or die) near ((tape or polyimide) or substrate))) and (crack or cracking or bulging or bulge or bend or bending)	USPAT	2003/04/07 01:57

37	22	(((((chip or die) and ((tape or polyimide) near substrate)) and (@ad<19980728)) and ((chip or die) near ((tape or polyimide) or substrate))) and (crack or cracking or bulging or bulge or	USPAT	2003/04/07
38	1	bend or bending)) and reflow ("5261593").PN.	USPAT	2003/04/07 02:11
39	o	("L36 and (solder adj ball\$2)").PN.	USPAT	2003/04/07 02:11
40	25	<pre>(((((chip or die) and ((tape or polyimide) near substrate)) and (@ad<19980728)) and ((chip or die) near ((tape or polyimide) or substrate))) and (crack or cracking or bulging or bulge or bend or bending)) and (solder adj ball\$2)</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/07 02:12
41	22	((((((chip or die) and ((tape or polyimide) near substrate)) and (@ad<19980728)) and ((chip or die) near ((tape or polyimide) or substrate))) and (crack or cracking or bulging or bulge or bend or bending)) and (solder adj ball\$2)) and adhesive	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/04/07 02:34
42	122	(chip or die) and ((tape or polyimide) near (interposer or buffer))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/04/07 02:36
44	2	(((chip or die) and ((tape or polyimide) near (interposer or buffer))) and (solder adj ball)) and (@ad<19980728)	USPĀT	2003/04/07 02:37
43	20	((chip or die) and ((tape or polyimide) near (interposer or buffer))) and (solder adj ball)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/04/07 02:48
45	3994	((crack or cracking or bulging or bulge or bend or bending) near (prevent or eliminate or stop)) and (chip or die or device)	USPĀT	2003/04/07 02:51
46	3296	(((crack or cracking or bulging or bulge or bend or bending) near (prevent or eliminate or stop)) and (chip or die or device)) and (@ad<19980728)	USPAT	2003/04/07 02:48
47	18	((((crack or cracking or bulging or bulge or bend or bending) near (prevent or eliminate or stop)) and (chip or die or device)) and (@ad<19980728)) and (solder	USPAT; US-PGPUB; EPO; JPO; DERWENT;	2003/04/07 02:48
48	15	adj ball) and adhesive (((crack or cracking or bulging or bulge or bend or bending) and (tape or polyimide)) near (prevent or eliminate or stop)) and (chip or die or device)	IBM_TDB USPAT	2003/04/07 03:10
49	1	("5917234").PN.	USPAT	2003/04/07 03:11
50	2	("10173303").PN.	JPO; DERWENT	2003/04/07 03:11
51	49	<pre>(tape or polyimide) near (substrate and (permeability or permeable or porous or matrix or comb))</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/04/07 03:18
52	10	((tape or polyimide) near (substrate and (permeability or permeable or porous or matrix or comb))) and (chip or die)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/04/07 03:14
53	4	<pre>(tape or polyimide) near (substrate and (permeability or permeable))</pre>	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/04/07 03:18

54	306	(tape or polyimide) with (substrate and	USPAT;	2003/04/07
1		(permeability or permeable))	US-PGPUB;	03:19
			EPO; JPO;	
			DERWENT;	
			IBM TDB	
55	7	((tape or polyimide) with (substrate and	USPAT	2003/04/07
	İ	(permeability or permeable))) and ((chip		03:19
Ì		or die) and (bulging or bulge or crack or		
		cracking))		